

**Search Notes**

Application/Control No.

10/811,396

Examiner

Anabel M. Ton

Applicant(s)/Patent under  
Reexamination

CHANG, SHIH-YUAN

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	249	12/9/2005	AT
	800		
	240		
	244		
	237		
	238		
	335		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR